Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | OHNISHI, SADAYUKI | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0173908 A1	09-2004	Barth et al.	257/760
	В	US-			
	O	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	·				
	0					
	Р					
	σ					
	R					
	s					
	Т					•

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	כ	
	>	
	8	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.